Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,166	NAKAMURA ET AL.	
Examiner	Art Unit	
Sikyin Ip	1742	

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Class	Subclass	Date	Examiner
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148	420	1/7/2007	SI
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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